

Notice of References Cited	Application/Control No. 10/572,758	Applicant(s)/Patent Under Reexamination LAU ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,343,920	02-2002	Terasaki et al.	425/143
*	B	US-5,597,588	01-1997	Totani et al.	425/143
*	C	US-5,741,449	04-1998	Yamamura et al.	264/40.6
*	D	US-5,456,870	10-1995	Bulgrin, Thomas C.	264/40.6
*	E	US-5,397,515	03-1995	Searle et al.	264/40.6
*	F	US-5,159,957	11-1992	Hehl, Karl	137/883
*	G	US-5,149,193	09-1992	Faillace, Louie M.	264/40.6
*	H	US-4,480,981	11-1984	Togawa et al.	425/143
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	61-235120	10-1986	Japan	---	---
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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